


<b>Search Notes</b>  	<b>Application/Control No.</b>  10529517	<b>Applicant(s)/Patent Under Reexamination</b>  IKEDA ET AL.
	<b>Examiner</b>  HENOK G HEYI	<b>Art Unit</b>  2627

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST, specifically 369/30.13 (text search only - please see search history printout)	02/27/2009	HH
search updated.	09/04/2009	HH

INTERFERENCE SEARCH			
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